N-channel TrenchMOS logic level FET

Rev. 02 — 30 November 2009

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

 Suitable for logic level gate drive sources

1.3 Applications

Table 4

General purpose switching

Out als references

Switched-mode power supplies

1.4 Quick reference data

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	60	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V};$ see <u>Figure 1</u> and <u>3</u>	-	-	34	А
P _{tot}	total power dissipation	$T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 2}{\text{Figure } 2}$	-	-	97	W
Dynamic	characteristics					
Q _{GD}	gate-drain charge	V _{GS} = 5 V; I _D = 20 A; V _{DS} = 44 V; T _j = 25 °C; see <u>Figure 12</u>	-	8.5	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C}$	-	31.5	43	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C};$ see Figure 10 and 11	-	30	40	mΩ



2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		-
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

SOT78 (TO-220AB)

3. Ordering information

Table 3.Ordering information

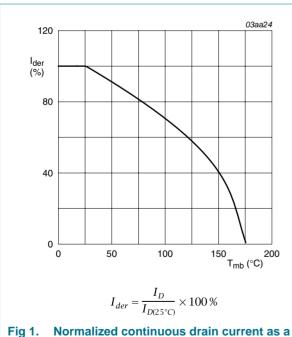
Type number	Package		
	Name	Description	Version
PHP32N06LT	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

4. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	60	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	60	V
V _{GS}	gate-source voltage		-15	15	V
I _D	drain current	$V_{GS} = 5 \text{ V}; T_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{100 \text{ C}}$	-	24	А
		$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{2} \text{ and } \frac{3}{2}$	-	34	А
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	136	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	97	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
V _{GSM}	peak gate-source voltage	pulsed; t _p ≤ 50 µs	-20	20	V
Source-dr	ain diode				
I _S	source current	T _{mb} = 25 °C	-	34	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	136	А
Avalanche	e ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; I_D = 20 A; V_{sup} ≤ 25 V; unclamped; t_p = 0.11 ms; R_{GS} = 50 Ω	-	100	mJ



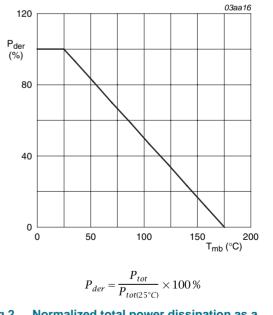
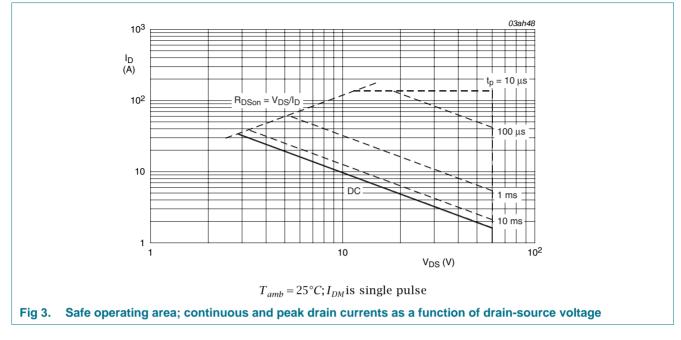




Fig 1. Normalized continuous drain current as a function of mounting base temperature

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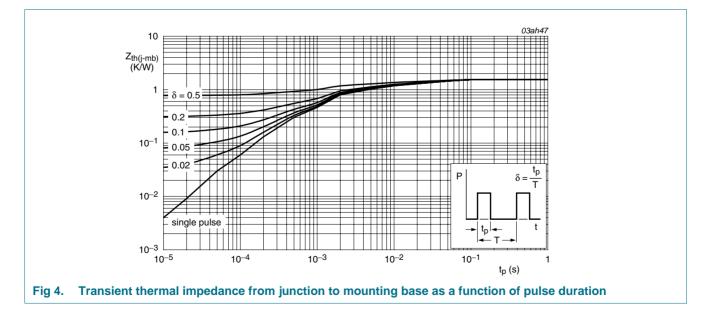
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5. Thermal characteristics

Table 5.Thermal characteristics

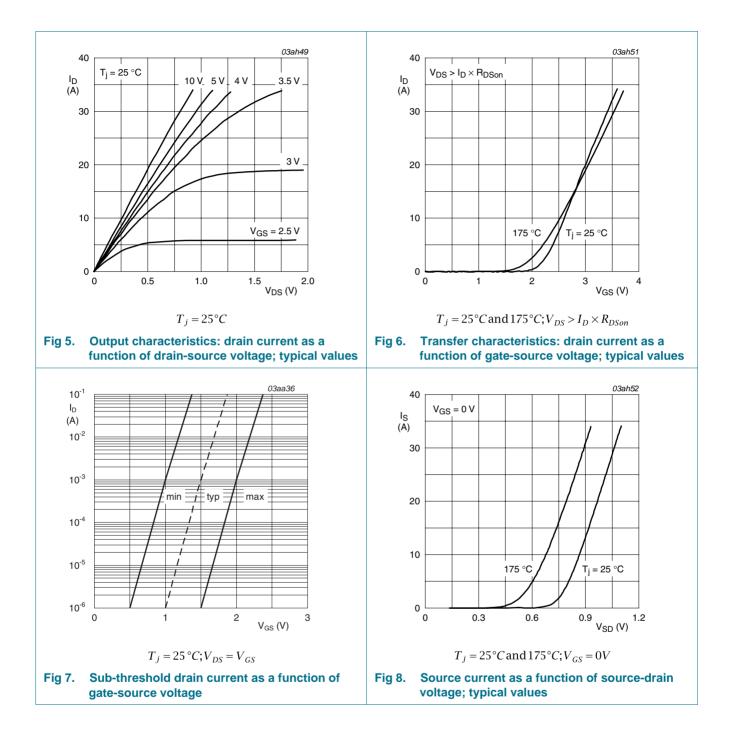
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	1.55	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W



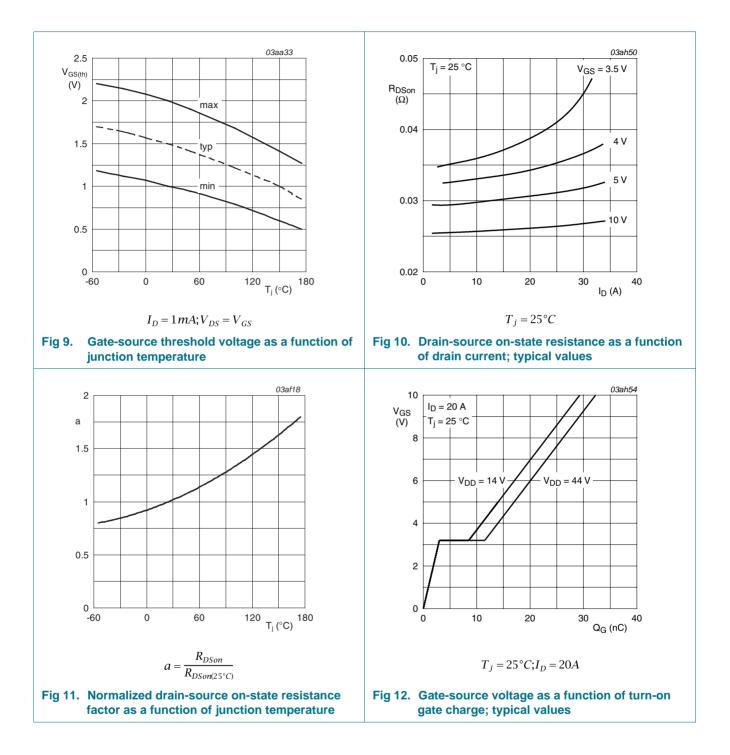
6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS} drain-source breakdown voltage		I_D = 0.25 mA; V_{GS} = 0 V; T_j = -55 °C	55	-	-	V
	I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	60	-	-	V	
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 9</u>	-	-	2.3	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; see <u>Figure 9</u>	1	1.5	2	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 175 °C; see <u>Figure 9</u>	0.5	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μA
		$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
		V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V_{GS} = 4.5 V; I_D = 20 A; T_j = 25 °C	-	31.5	43	mΩ
	resistance	V _{GS} = 5 V; I _D = 20 A; T _j = 175 °C; see <u>Figure 10</u> and <u>11</u>	-	-	84	mΩ
		V_{GS} = 10 V; I _D = 20 A; T _j = 25 °C	-	26	37	mΩ
		V _{GS} = 5 V; I _D = 20 A; T _j = 25 °C; see <u>Figure 10</u> and <u>11</u>	-	30	40	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 20 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	17	-	nC
Q_{GS}	gate-source charge	$T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 12}{\text{Figure } 12}$	-	3	-	nC
Q_{GD}	gate-drain charge		-	8.5	-	nC
C _{iss}	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	920	1280	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 13$	-	160	200	pF
C _{rss}	reverse transfer capacitance		-	100	155	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	14	-	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; T_j = 25 \ ^{\circ}C$	-	120	-	ns
t _{d(off)}	turn-off delay time		-	45	-	ns
t _f	fall time		-	55	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 8</u>	-	1	1.2	V
t _{rr}	reverse recovery time	I _S = 20 A; dI _S /dt = -100 A/μs; V _{GS} = -10 V;	-	36	-	ns
Qr	recovered charge	V _{DS} = 30 V; T _j = 25 °C	-	70	-	nC

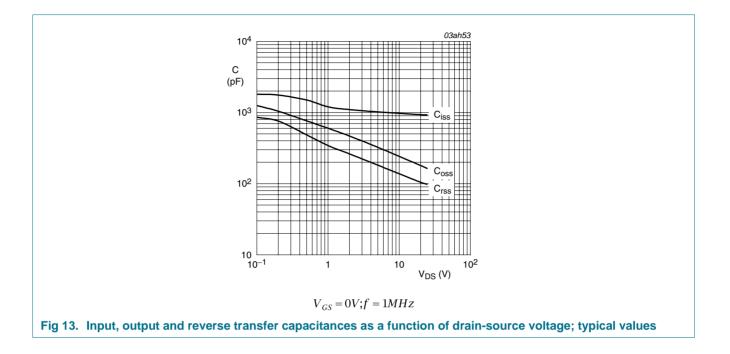
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7. Package outline

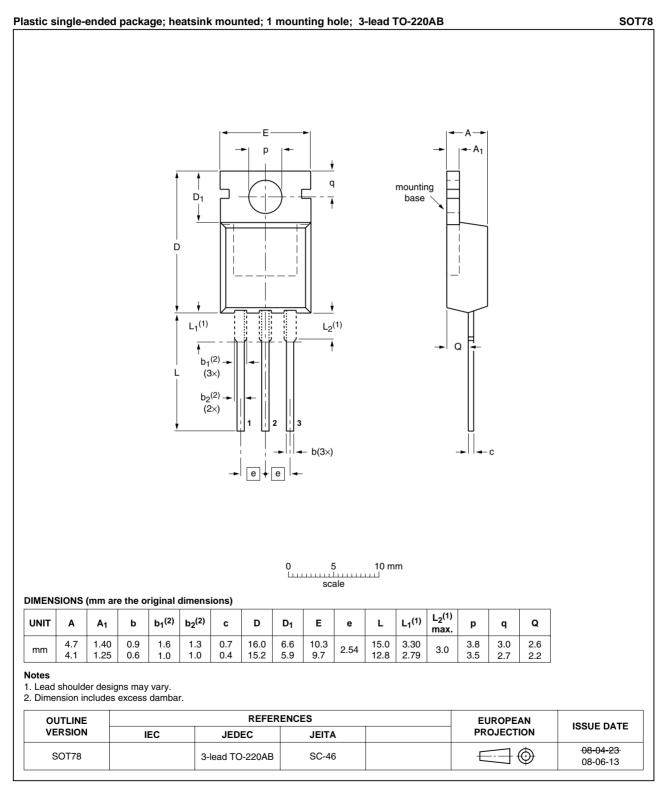


Fig 14. Package outline SOT78 (TO-220AB)

8. Revision history

Table 7. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PHP32N06LT_2	20091130	Product data sheet	-	PHP_PHB_32N06LT-01
Modifications:		of this data sheet has bee of NXP Semiconductors.	n redesigned to comply	with the new identity
	 Legal texts 	have been adapted to the	new company name wh	ere appropriate.
PHP_PHB_32N06LT-01 (9397 750 09024)	20011106	Product data	-	-

PHP32N06LT_2

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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